Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/777,465	LINN ET AL.
Examiner	Art Unit
Hwei-Siu C. Payer	3724

	SEAR	CHED	
Class	Subclass	Date	Examiner
030	160 161	updated m 3/1/06	Payer

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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